

Notice of References Cited	Application/Control No. 10/522,754	Applicant(s)/Patent Under Reexamination MIYAKE ET AL.	
	Examiner Rei-tsang Shiao, Ph.D.	Art Unit 1626	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Itakura et al., 1999, CAS: 130:168016.
	V	Ko et al., 1995, CAS: 122:290332.
	W	Yamazaki et al., 1979, CAS: 90:168087.
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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